## Massachusetts Institute of Technology Department of Electrical Engineering & Computer Science 6.041/6.431: Probabilistic Systems Analysis (Spring 2006)

## **Tutorial** March 9-10, 2006

1.

$$E[X] = \left[\frac{1}{\lambda}(2p-1)\right]$$

$$Var(X) = \left[\frac{2}{\lambda^2} - \frac{1}{\lambda^2}(2p-1)^2\right]$$

2.

$$\mathbf{P}(1 \le X \le 3) = \frac{2}{3} (2\Phi(1) - 1) + \frac{1}{3} \left( 2\Phi\left(\frac{1}{3}\right) - 1 \right).$$

3.

(a) Using the total expectation theorem, we obtain

$$\mathbf{E}[X] = \mathbf{E}[X|A]\mathbf{P}(A) + \mathbf{E}[X|B]\mathbf{P}(B) = 1 * \frac{1}{2} + \frac{1}{3} * \frac{1}{2} = \frac{2}{3}$$

(b) Using the total probability theorem, we obtain

$$\mathbf{P}(D) = \mathbf{P}(D|A)\mathbf{P}(A) + \mathbf{P}(D|B)\mathbf{P}(B) = \frac{1}{2}e^{-\tau} + \frac{1}{2}e^{-3\tau}$$

(c) Using the Bayes' theorem, we obtain  $\mathbf{P}(T_{1A}|D) = \frac{1}{1+e^{-2\tau}}$ 

$$\mathbf{P}(T_{1A}|D) = \frac{1}{1 + e^{-2\tau}}$$

(d) Using the total expectation theorem, we obtain

 $\mathbf{E}[\text{Total Time Till Failure} \mid D]$ 

$$= \tau + \mathbf{E}[\text{Time to failure after } \tau \mid D, A]\mathbf{P}(A|D) + \mathbf{E}[\text{Time to failure after } \tau \mid D, B]\mathbf{P}(B|D)$$

$$= \tau + \frac{1}{1 + e^{-2\tau}} + (\frac{1}{3})\frac{e^{-2\tau}}{1 + e^{-2\tau}}$$